

MH187 Hall-effect sensor is a temperature stable, stress-resistant latch. Superior high-temperature performance is made possible through a dynamic offset cancellation that utilizes chopper-stabilization. This method reduces the offset voltage normally caused by device over molding, temperature dependencies, and thermal stress.

MH187 includes the following on a single silicon chip: voltage regulator, Hall voltage generator, small-signal amplifier, chopper stabilization, Schmitt trigger, ESD circuit protection, open-drain output. Advanced CMOS wafer fabrication processing is used to take advantage of low-voltage requirements, component matching, very low input-offset errors, and small component geometries.

This device requires the presence of both south and north polarity magnetic fields for operation. In the presence of a south polarity field of sufficient strength, the device output latches on, and only switches off when a north polarity field of sufficient strength is present.

MH187 is rated for operation between the ambient temperatures  $-40^{\circ}\text{C}$  and 85°C for the E temperature range, and  $-40^{\circ}\text{C}$  to 125°C for the K temperature range. The three package styles available provide magnetically optimized solutions for most applications. Package types SO is an SOT-23(1.1 mm nominal height), SQ is an QFN2020-3(0.5 mm nominal height), a miniature low-profile surface-mount package, while package UA is a three-lead ultra-mini SIP for through-hole mounting.

The UA package SO type and SQ type are Halogen Free package. All of them have been verified by third party Lab.

#### Features and Benefits

- Chopper stabilized amplifier stage
- Optimized for BLDC motor applications
- Reliable and low shifting on high Temp condition
- Good ESD Protection
- 100% tested at 125 °C for K.
- 100% tested at 150 °C for L.
- Custom sensitivity / Temperature selection are available.
- RoHS compliant 2011/65/EU and Halogen Free

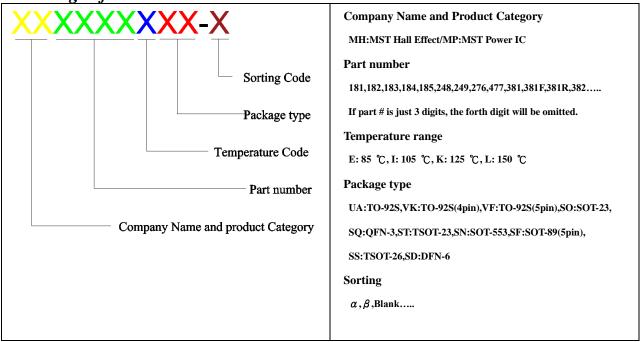
#### **Applications**

- High temperature Fan motor
- 3 phase BLDC motor application
- Speed sensing
- Position sensing
- Current sensing
- Revolution counting
- Solid-State Switch
- Linear Position Detection
- Angular Position Detection
- Proximity Detection
- High ESD Capability

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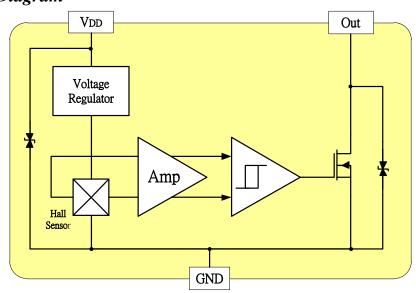
**Ordering Information** 



Part No.	Temperature Suffix	Package Type
MH187LUA	$L (-40^{\circ}C \text{ to} + 150^{\circ}C)$	UA (TO-92S)
MH187KUA	K ( $-40^{\circ}$ C to + $125^{\circ}$ C)	UA (TO-92S)
MH187KSO	K (- $40^{\circ}$ C to + $125^{\circ}$ C)	SO (SOT-23)
MH187KSQ	K ( $-40^{\circ}$ C to + $125^{\circ}$ C)	SQ (QFN2020-3)
MH187EUA	E $(-40^{\circ}\text{C to} + 85^{\circ}\text{C})$	UA (TO-92S)
MH187ESO	$E (-40^{\circ}C \text{ to} + 85^{\circ}C)$	SO (SOT-23)
MH187ESQ	E $(-40^{\circ}\text{C to} + 85^{\circ}\text{C})$	SQ (QFN2020-3)

KUA spec is using in industrial and automotive application. Special Hot Testing is utilized.

### Functional Diagram





**Absolute Maximum Ratings** At (Ta=25°C)

Characteristics			Values	Unit
Supply voltage, $(V_{DD})$			28	V
Output Voltage,(Vout)			28	V
Reverse voltage, $(V_{DD})$ $(V_{OUT})$			-0.3	V
Output current, $(I_{OUT})$			50	mA
		"E" version	-40 to +85	°C
Operating Temperature Range, (Ta)		"K" version	-40 to +125	°C
		"L" version	-40 to +150	°C
Storage temperature range, ( <i>Ts</i> )			-65 to +175	°C
Maximum Junction Temp,( <i>Tj</i> )			175/150	°C
Thermal Resistance	(θja) l	UA/SO/SQ	206 / 543 / 543	°C/W
	(θjc) I	JA/SO/SQ	148 / 410 / 410	°C/W
Package Power Dissipation, (P <sub>D</sub> ) UA / SO / SQ			728 / 230 / 230	mW

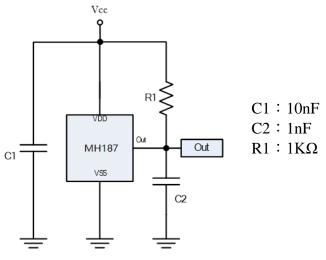
 $\textit{Note: Do not apply reverse voltage to $V_{DD}$ and $V_{OUT}$ Pin, It may be caused for Miss function or damaged device.}$ 

### **Electrical Specifications**

DC Operating Parameters:  $T_A=+25$ °C,  $V_{DD}=12V$ 

Parameters	<b>Test Conditions</b>	Min	Тур	Max	Units
Supply Voltage, $(V_{DD})$	Operating	3.0		26.0	V
Supply Current, $(I_{DD})$	B <bop< td=""><td></td><td></td><td>5.0</td><td>mA</td></bop<>			5.0	mA
Output Saturation Voltage, (Vsat)	IOUT = 20 mA, B>BOP			400.0	mV
Output Leakage Current, (Ioff)	IOFF B <brp, vout="12V&lt;/td"><td></td><td></td><td>15.0</td><td>uA</td></brp,>			15.0	uA
Output Rise Time, (TR)	RL= $1.1$ K $\Omega$ , CL = $20$ pF			0.45	uS
Output Fall Time, (TF)	RL=820Ω; CL =20pF			0.45	uS
Electro-Static Discharge	НВМ	4			KV
Operate Point,(BOP)		15		60	Gauss
Release Point,(BRP)		-60		-15	Gauss
Hysteresis,(BHYS)			80		Gauss

## Typical application circuit

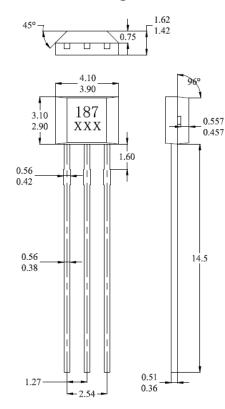


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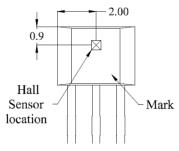


## Sensor Location, package dimension and marking

#### **UA Package**



## Hall Chip location

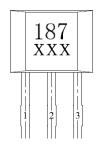


#### **NOTES:**

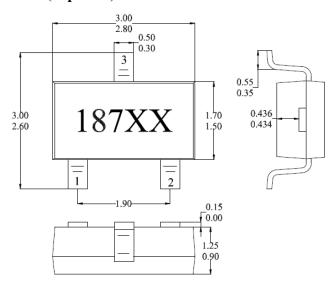
- 1).Controlling dimension: mm
- 2).Leads must be free of flash and plating voids
- 3).Do not bend leads within 1 mm of lead to package interface.
- 4).PINOUT:

Pin 1	VDD
Pin 2	GND
Pin 3	Output

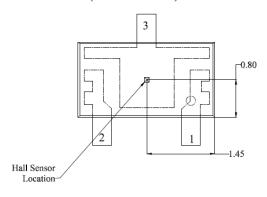
# Output Pin Assignment (Top view)



## SO Package (Top View)



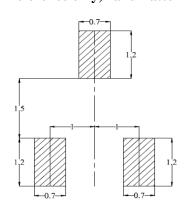
## Hall Plate Chip Location (Bottom View)



#### **NOTES:**

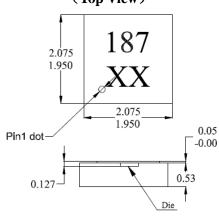
- 1. PIN OUT (See Top View at left :)
  Pin 1 V<sub>DD</sub>; Pin 2 Output; Pin 3 GND
- 2. Controlling dimension: mm
- 3. Lead thickness after solder plating will be 0.254mm maximum

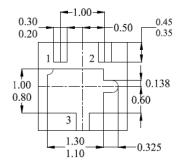
#### (For reference only)Land Pattern





# SQ Package (Top View)



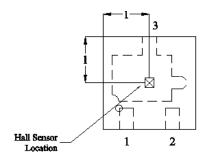


Bottom View

#### **NOTES:**

- 1. PINOUT (See Top View at left)
  Pin1 VDD; Pin2 Output; Pin3 GND
- 2. Controlling dimension: mm;
- 3. Chip rubbing will be 10mil maximum;
- 4. Chip must be in PKG. center.

# Hall Plate Chip Location (Top view)



#### (For reference only)Land Pattern

